



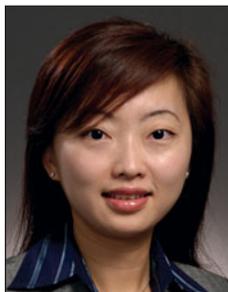
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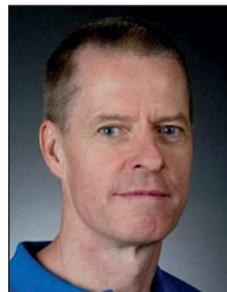


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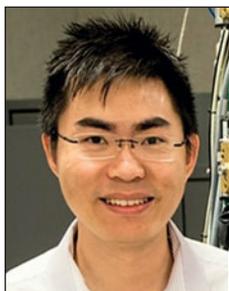
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Ross received her BA degree in physics and PhD degree in materials science from Cambridge University. Her postdoc was at AT&T Bell Laboratories. She then joined the National Center for Electron Microscopy, Lawrence Berkeley National Laboratory, and later moved to the IBM T.J. Watson Research Center. Her interests include liquid cell microscopy, epitaxy, nanowire growth, electrodeposition, and thin-film properties. She has received the UK Institute of

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His current research interests include *in situ*

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Wang is a staff scientist at the Environmental Molecular Sciences Laboratory, Pacific Northwest National Laboratory. He received his BS and MS degrees in physics from Lanzhou University, China, and his PhD degree in materials science and engineering from the University of Leeds, UK. Previously, he worked at Max Planck Institute for Metal Research in Germany, the National Institute for Materials Science in Japan,

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